

HASO LIFT 680

Wavefront sensor The Best-in-class

Ultra-high spatial resolution High accuracy Alignment-free









HASO LIFT 680 $\,+\,$

For the HASO LIFT 680,
Imagine Optic has
merged the reliability
and accuracy of a ShackHartmann wavefront
sensor with the ultrahigh resolution of LIFT.

This generation features the new SpotTracker™ technology. It provides absolute wavefront and tilt information, eliminating alignment requirements for faster and easier implementation.



Compatible with the Optical Engineer Companion modular system: easily combine the accessories you

APPLICATIONS

Successfully used in the most demanding applications in optical metrology, microscopy, and laser diagnostics, the HASO LIFT 680 performs multiple functions :

- + Characterize complex optics, including meta-surface and freeform optics
- + Quantify laser impact (LIDT)
- + Perform surface characterization on high and middle frequencies mirrors
- + Predict the performance of optical systems in terms of focusing capability or imaging quality
- + Quantify the effects of temperature and gravity on system performance
- + Drive a wavefront corrector to correct for system aberrations

FEATURES

HASO LIFT 680 enables you to perform multiple functions by combining :

- + Ultra-high spatial resolution of 680 x 504, allowing characterization over several hundreds of Zernike polynomials
- + Accuracy of $\lambda/100$ RMS permitting small defects detection
- + Dynamic range superior to 1000 λ for direct wavefront acquisition of converging and diverging beams



SPECIFICATIONS*

OPERATING SPECS

Aperture dimension
Phase points resolution
Number of microlenses
Maximum acquisition frequency
Calibrated wavelength range
Minimum power
External trigger
Operating system

OPTICAL SPECS

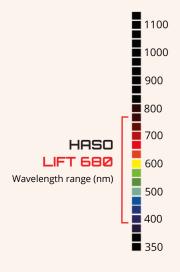
Repeatability
Absolute wavefront measurement accuracy
Spatial sampling
Tilt dynamic range
Focus dynamic range

MISC

Dimension (Height x Width x Length) Weight for USB version Working temperature Interface Power consumption 13.8 x 10.2 mm²
680 x 504
170 x 126
30 Hz (USB 3.0) or 8 Hz (GigE)
400 - 750 nm
0.7 nW
TTL signal
Windows 10

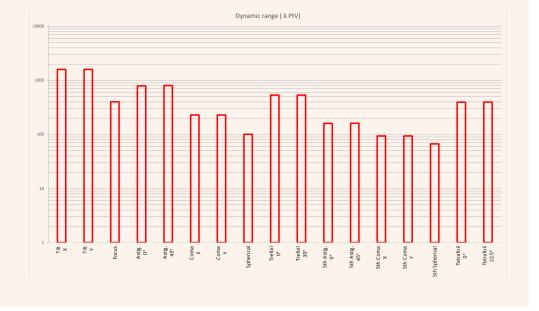
 $< \lambda/200$ RMS $\lambda/100$ or 6 nm RMS $\sim 20~\mu m$ $> \pm 3^{\circ}$ ± 0.004 m to $\pm \infty$

47 x 62 x 60 mm³ (USB 3.0) 200 g 15 - 30 °C USB 3.0 or GigE 3.6 W



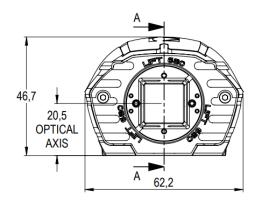
HASO LIFT 680

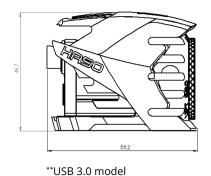
Dynamic range at λ = 635 nm



 * Subject to changes without further notice

DIMENSIONS (mm)**





SOFTWARE

WAVEVIEW™ Metrology Software

WAVEVIEW™ is the most advanced wavefront measurement and analysis software.

It offers more than 150 features and tools optimized for a wide range of highly demanding applications.

Options:

- + Extensions for PSF, MTF and Strehl ratio
- + Optional SDK in C/C++, LabVIEW and Python

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WAVETUNE™ Adaptive Optics Software

WAVETUNE™ is a unique software that seamlessly combines wavefront measurement and correction features with extensive instrument diagnostics. It is perfectly adapted to our HASO wavefront sensors, ILAO STAR, MIRAO and mu-DM deformable mirrors, as well as to a wide range of active components.

Options:

+ Optional SDK in C/C++, LabVIEW and Python

